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**Examiner**

Hieu P. Nguyen

**Applicant(s)/Patent under Reexamination**

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**Art Unit**

2817

**SEARCHED**

Class	Subclass	Date	Examiner
330	51	7/24/2007	HN
330	295	7/24/2007	HN
330	133	8/1/2007	HN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
MOTTOLA STEVEN J	7/29/2007	HN
EAST UPDATE SEARCH	12/7/2007	HN